

High-Side and Low-Side Gate Driver

FAN7382

The FAN7382, a monolithic high and low side gate-drive IC, can drive MOSFETs and IGBTs that operate up to +600 V. **onsemi's** high-voltage process and commonmode noise canceling technique provides stable operation of the high-side driver under high-dv/dt noise circumstances. An advanced level-shift circuit allows high-side gate driver operation up to $V_S = -9.8~V~(typical)$ for $V_{BS} = 15~V.$ The input logic level is compatible with standard TTL-series logic gates. UVLO circuits for both channels prevent malfunction when V_{CC} or V_{BS} is lower than the specified threshold voltage. Output drivers typically source/sink 350 mA/650 mA, respectively, which is suitable for fluorescent lamp ballasts, PDP scan drivers, motor controls, etc.

Features

- Floating Channels Designed for Bootstrap Operation to +600 V
- Typically 350 mA/650 mA Sourcing/Sinking Current Driving Capability for Both Channels
- Common-Mode dv/dt Noise Canceling Circuit
- Extended Allowable Negative V_S Swing to -9.8 V for Signal Propagation at V_{CC} = V_{BS} = 15 V
- V_{CC} & V_{BS} Supply Range from 10 V to 20 V
- UVLO Functions for Both Channels
- TTL Compatible Input Logic Threshold Levels
- Matched Propagation Delay Below 50 ns
- Output In-phase with Input Signal
- These are Pb-Free Devices

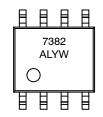




SOIC14 N CASE 751ER

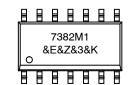
MARKING DIAGRAMS

SOIC8



7382 = Device Code
A = Assembly Site
L = Wafer Lot Number
YW = Assembly Start Week

SOIC14 N



7382M1 = Device Code &E = Designates Space &Z = Assembly Location &3 = 3-Digit Date Code

&K = 2-Digits Lot Run Traceability Code

ORDERING INFORMATION

See detailed ordering and shipping information on page 12 of this data sheet

Typical Application Circuit

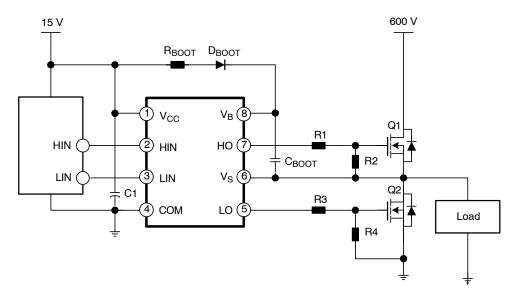


Figure 1. Application Circuit for Half-Bridge

Internal Block Diagram

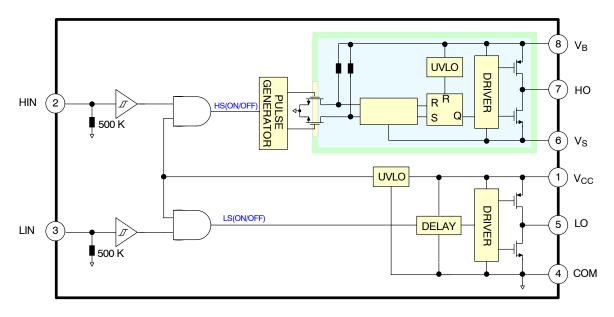
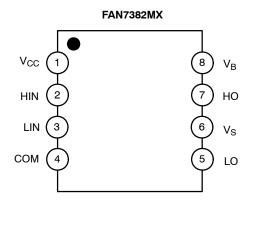


Figure 2. Functional Block Diagram

Pin Assignments



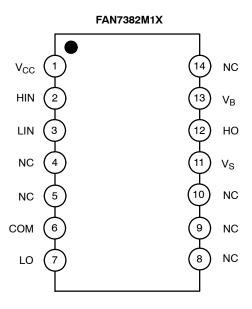


Figure 3. Pin Configuration (Top View)

PIN DIFINITIONS

Name	Description
V _{CC}	Low-Side Supply Voltage
HIN	Logic Input for High-Side Gate Driver Output
LIN	Logic Input for Low-Side Gate Driver Output
COM	Logic Ground and Low-Side Driver Return
LO	Low-Side Driver Output
Vs	High-Voltage Floating Supply Return
НО	High-Side Driver Output
V _B	High-Side Floating Supply

ABSOLUTE MAXIMUM RATINGS

Parameter		Symbol	Min	Max	Unit
High-Side Offset Voltage		V _S	V _B – 25	V _B + 0.3	V
High-Side Floating Supply Voltage		V_{B}	-0.3	625	
High-Side Floating Output Voltage HO		V_{HO}	V _S - 0.3	V _B + 0.3	
Low-Side and Logic Fixed Supply Voltage		V_{CC}	-0.3	25	
Low-Side Output Voltage LO		V_{LO}	-0.3	V _{CC} + 0.3	
Logic Input Voltage (HIN, LIN)		V_{IN}	-0.3	V _{CC} + 0.3	
Logic Ground		COM	V _{CC} - 25	V _{CC} + 0.3	
Allowable Offset Voltage Slew Rate		dV _S /dt		50	V/ns
Power Dissipation		P _D	SOIC8	0.625	W
	(1	Notes 1, 2, 3)	SOIC14 N	1.0	
Junction temperature		T_J		150	°C
Storage Temperature		T _{STG}		150	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected. 1. Mounted on $76.2 \times 114.3 \times 1.6$ mm PCB (FR-4 glass epoxy material).

- 2. Refer to the following standards:
 - JESD51-2: Integral circuits thermal test method environmental conditions natural convection
- JESD51-3: Low effective thermal conductivity test board for leaded surface mount packages
- 3. Do not exceed P_D under any circumstances.

THERMAL CHARACTERISTICS

Parameter	Symbol	Min	Max	Unit
Thermal Resistance, Junction-to-Ambient	$\theta_{\sf JA}$	SOIC8	200	°C/W
		SOIC14 N	110	

RECOMMENDED OPERATING CONDITIONS

Parameter	Symbol	Min	Max	Unit
High-Side Floating Supply Voltage	V _B	V _S + 10	V _S + 20	V
High-Side Floating Supply Offset Voltage	V _S	6 – V _{CC}	600	V
High-Side (HO) Output Voltage	V _{HO}	V _S	V _B	V
Low-Side (LO) Output Voltage	V_{LO}	СОМ	V _{CC}	V
Logic Input Voltage (HIN, LIN)	V _{IN}	COM	V _{CC}	V
Low-Side Supply Voltage	V _{CC}	10	20	V
Ambient Temperature	T _A	-40	125	°C

Functional operation above the stresses listed in the Recommended Operating Ranges is not implied. Extended exposure to stresses beyond the Recommended Operating Ranges limits may affect device reliability.

ELECTRICAL CHARACTERISTICS

 V_{BIAS} (V_{CC} , V_{BS}) = 15.0 V, T_A = 25°C, unless otherwise specified. The V_{IN} and I_{IN} parameters are referenced to COM. The V_O and I_O parameters are referenced to V_S and COM and are applicable to the respective outputs HO and LO.

Parameter	Test Condition	Symbol	Min	Тур	Max	Unit
V _{CC} and V _{BS} Supply Under-Voltage Positive Going Threshold		V _{CCUV+} V _{BSUV+}	8.2	9.2	10.0	V
V _{CC} and V _{BS} Supply Under-Voltage Positive Going Threshold		V _{CCUV} - V _{BSUV} -	7.6	8.7	9.6	V
V _{CC} Supply Under-Voltage Lockout Hysteresis		V _{CCUVH} V _{BSUVH}		0.6		V
Offset Supply Leakage Current	V _B = V _S = 600 V	I _{LK}			50	μΑ
Quiescent V _{BS} Supply Current	V _{IN} = 0 V or 5 V	I _{QBS}		45	120	μΑ
Quiescent V _{CC} Supply Current	V _{IN} = 0 V or 5 V	I _{QCC}		70	180	μΑ
Operating V _{BS} Supply Current	f _{IN} = 20 kHz, rms value	I _{PBS}			600	μΑ
Operating V _{CC} Supply Current	f _{IN} = 20 kHz, rms value	I _{PCC}			600	μΑ
Logic "1" Input Voltage		V _{IH}	2.9			V
Logic "0" input voltage		V _{IL}			0.8	V
High-Level Output Voltage, V _{BIAS} - V _O	I _O = 20 mA	V _{OH}			1.0	V
Low-Level Output Voltage, VO		V _{OL}			0.6	V
Logic "1" Input Bias Current	V _{IN} = 5 V	I _{IN+}		10	20	μΑ
Logic "0" Input Bias Current	V _{IN} = 0 V	I _{IN} _		1.0	2.0	μΑ
Output High Short-Circuit Pulsed Current	$V_O = 0 \text{ V}, V_{IN} = 5 \text{ V}$ with PW < 10 μ s	I _{O+}	250	350		mA
Output Low Short-Circuit Pulsed Current	V_O = 15 V, V_{IN} = 0 V with PW < 10 μs	I _{O-}	500	650		mA
Allowable Negative VS Pin Voltage for HIN Signal Propagation to HO		V _S		-9.8	-7.0	V

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

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performance may not be indicated by the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

DYNAMIC ELECTRICAL CHARACTERISTICS

 V_{BIAS} (V_{CC} , V_{BS}) = 15.0 V, V_{S} = COM, C_{L} = 1000 pF and, T_{A} = 25°C, unless otherwise specified.

Parameter	Test Condition	Symbol	Min	Тур	Max	Unit
Turn-On Propagation Delay	V _S = 0 V	t _{on}	100	170	300	ns
Turn-Off Propagation Delay	V _S = 0 V or 600 V (Note 4)	t _{off}	100	200	300	ns
Turn-On Rise Time		t _r	20	60	140	ns
Turn-Off Fall Time		t _f		30	80	ns
Delay Matching, HS & LS Turn-On/Off		MT			50	ns

^{4.} This parameter guaranteed by design.

TYPICAL CHARACTERISTICS

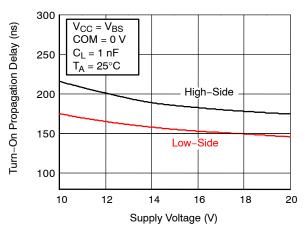


Figure 4. Turn-On Propagation Delay vs. Supply Voltage

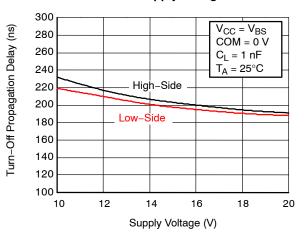


Figure 6. Turn-Off Propagation Delay vs. Supply Voltage

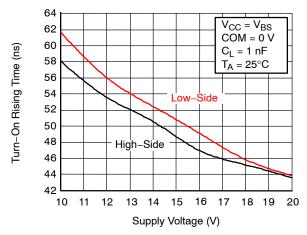


Figure 8. Turn-On Rising Time vs. Supply Voltage

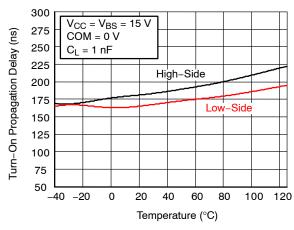


Figure 5. Turn-On Propagation Delay vs. Temperature

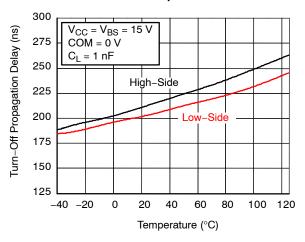


Figure 7. Turn-Off Propagation Delay vs. Temperature

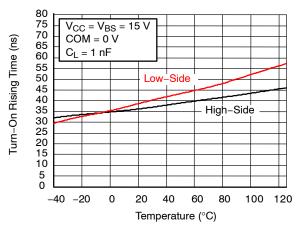


Figure 9. Turn-On Rising Time vs. Temperature

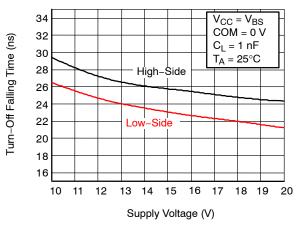


Figure 10. Turn-Off Falling Time vs. Supply Voltage

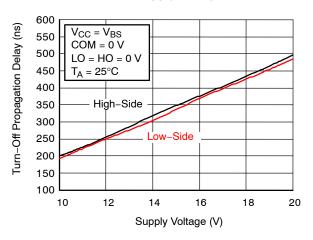


Figure 12. Output Sourcing Current vs. Supply Voltage

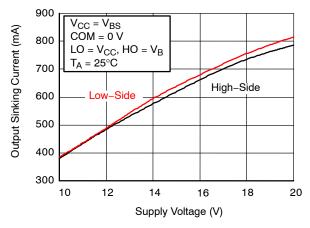


Figure 14. Output Sinking Current vs. Supply Voltage

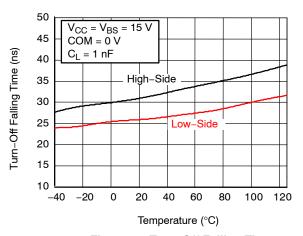


Figure 11. Turn-Off Falling Tim vs. Temperature

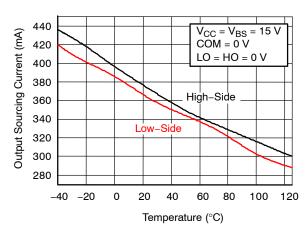


Figure 13. Output Sourcing Current vs. Temperature

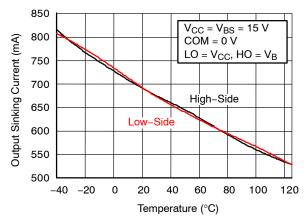


Figure 15. Output Sinking Current vs. Temperature

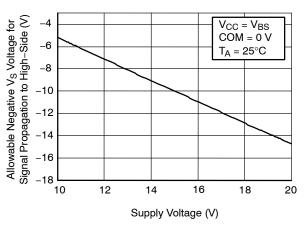


Figure 16. Allowable Negative V_S Voltage for Signal Propagation to High Side vs. Supply Voltage

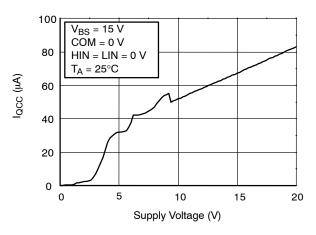


Figure 18. I_{QCC} vs. Supply Voltage

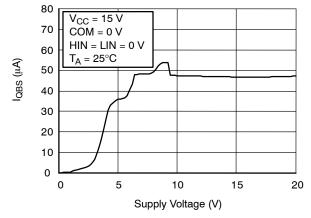


Figure 20. I_{QBS} vs. Supply Voltage

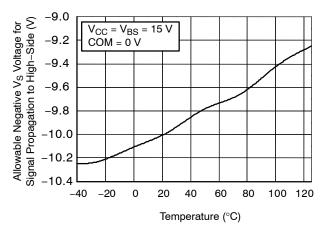


Figure 17. Allowable Negative V_S Voltage for Signal Propagation to High Side vs. Temperature

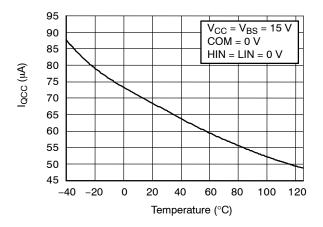


Figure 19. I_{QCC} vs. Temperature

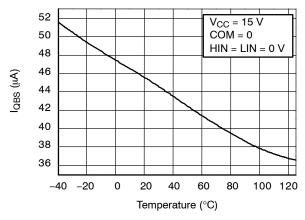


Figure 21. I_{QBS} vs. Temperature

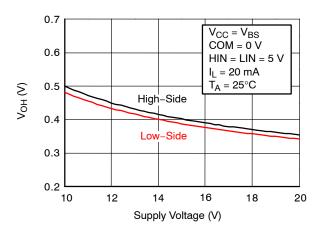


Figure 22. High-Level Output Voltage vs. Supply Voltage

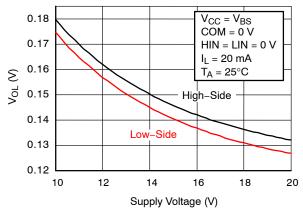


Figure 24. Low-Level Output Voltage vs. Supply Voltage

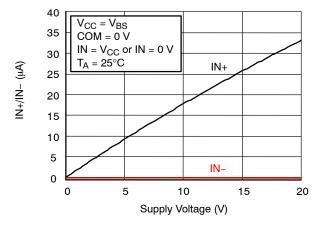


Figure 26. Input Bias Current vs. Supply Voltage

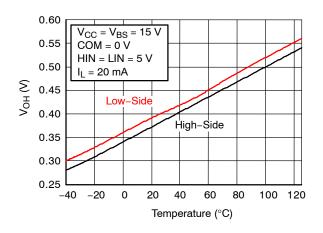


Figure 23. High-Level Output Voltage vs. Temperature

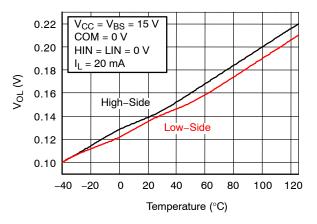


Figure 25. Low-Level Output Voltage vs. Temperature

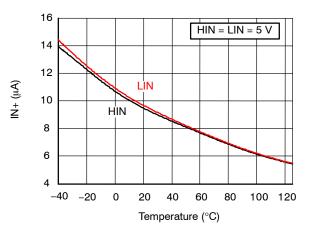


Figure 27. Input Bias Current vs. Temperature

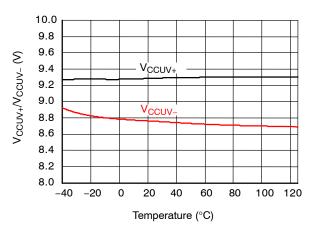


Figure 28. V_{CC} UVLO Threshold Voltage vs. Temperature

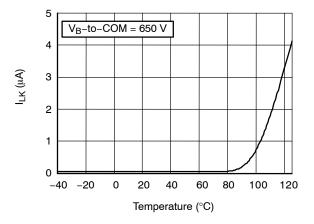


Figure 30. V_B to COM Leakage Current vs. Temperature

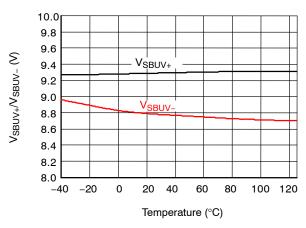


Figure 29. V_{BS} UVLO Threshold Voltage vs. Temperature

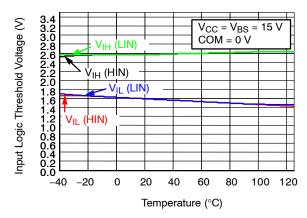
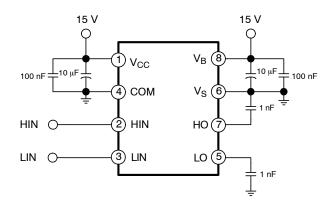


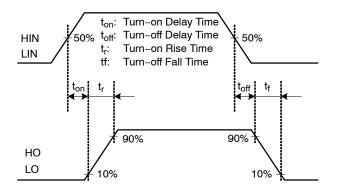
Figure 31. Input Logic Threshold Voltage vs. Temperature



HIN LIN LIN LO

Figure 32. Switching Time Test Circuit

Figure 33. Input / Output Timing Diagram





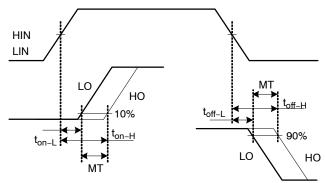


Figure 35. Delay Matching Waveform Definition

ORDERING INFORMATION

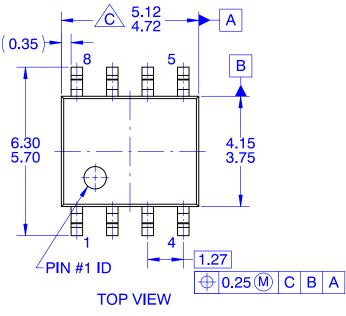
Part Number	Operating Temperature Range	Package	Shipping [†]
FAN7382MX (Note 5)	−40°C ~125°C	SOIC8 (Pb-Free)	3000 / Tape & Reel
FAN7382M1X (Note 5)		SOIC14 N (Pb-Free)	3000 / Tape & Reel

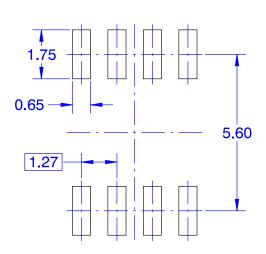
[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

5. These devices passed wave soldering test by JESD22A–111.

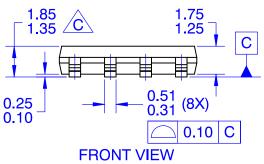
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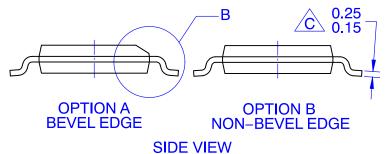
DATE 30 SEP 2016

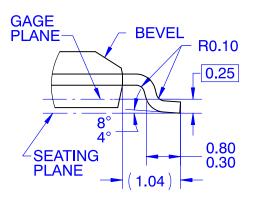




LAND PATTERN RECOMMENDATION







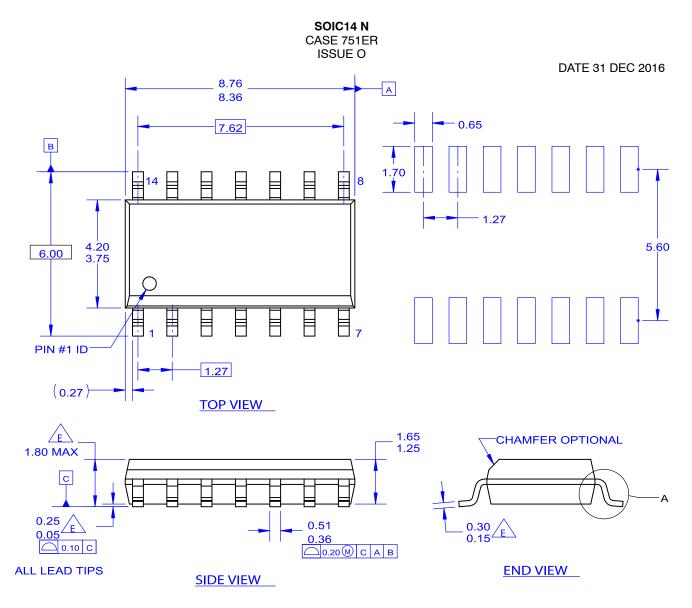
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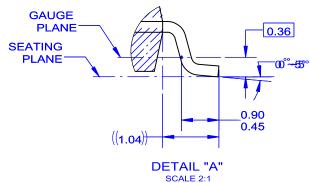
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